Unit: mm

TOSHIBA Diodes for Protecting against ESD Epitaxial Planar Type

## DF3A5.6FE

### Diodes for Protecting against ESD

- The mounting of two devices on an ultra-compact package allows the number of parts and the mounting cost to be reduced.
- The zener voltage corresponds to the E24 Series.

# 1. CATHODE1 2. CATHODE2 3. ANODE

## **Maximum Ratings (Ta = 25°C)**

Characteristic	Symbol	Rating	Unit
Power dissipation	Р	100	mW
Junction temperature	Tj	125	°C
Storage temperature range	T <sub>stg</sub>	-55~125	°C

Weight: 0.0023 g (typ.)

1-2SA1A

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#### **Electrical Characteristics (Ta = 25°C)**

Characteristic	Symbol	Test Condition	Min	Тур.	Max	Unit
Zener voltage	VZ	I <sub>Z</sub> = 5mA	5.3	5.6	6.0	V
Dynamic impedance	Z <sub>Z</sub>	I <sub>Z</sub> = 5mA	_	_	40	Ω
Reverse current	I <sub>R</sub>	V <sub>R</sub> =2.5V	_	_	1.0	μA
Terminal capacitance (between Cathode and Anode)	C <sub>T</sub>	V <sub>R</sub> = 0, f = 1MHz	_	65	_	pF

#### **Guaranteed Level of ESD Immunity**

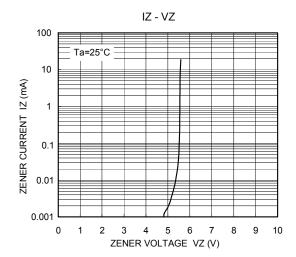
Test Condition	ESD Immunity Level
IEC61000-4-2 (Contact discharge)	± 30kV

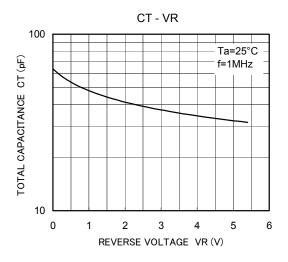
Criterion: No damage to device elements

# Marking Equivalent Circuit (top view)









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